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FORM PTO-1449	ORM PTO-1449 U.S. DEPARTMENT OF COMMERC		APPLICATION NO. 10/743072	
LIST OF REF	ERENCES CITED BY APPLICANT	FIRST NAMED INVENTOR Hiroshi WATANABE, et al.		
ı	(Use several sheets if necessary)	FILING DATE December 23, 2003	GROUP ART UNIT	

**U.S. PATENT DOCUMENTS** 

EXAMINER INITIAL		DOCUMENT NO.	DATE	NAME	CLASS	SUB- CLASS	FILING DATE
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**FOREIGN PATENT DOCUMENTS** 

		DOCUMENT NO.	DATE	COUNTRY	CLASS	SUB- CLASS	TRANSI YES	ATION NO
TWA	AE	4-201225	07/1992	Japan			abs	
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TWH	AG	51-73563	06/1976	Japan				Х
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OTHER REFERENCES (INCLUDING AUTHOR, TITLE, DATE, PERTINENT PAGES, ETC.)

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Sheet 1 of 1 APPLICATION NO. ATTORNEY DOCKET NO. FORM PTO-1449 U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE 10/743,072 392.1852 FIRST NAMED INVENTOR CAREFERENCES CITED BY APPLICANT Hiroshi WATANABE, et al. FILING DATE **GROUP ART UNIT** JUN 2 1 2004 (Use several sheets if necessary) TRADEN' 1722 December 23, 2003 **U.S. PATENT DOCUMENTS** SUB-FILING DOCUMENT \*EXAMINER DATE CLASS INITIAL NO. DATE NAME **CLASS** AA 4,879,077 11/1989 Shimizu et al. 2001/005339 AB 12/2001 Suganuma et al. 2 A1 AC 4,695,237 09/1987 Inaba AD 5,002,717 03/1991 Taniguchi AE AF **FOREIGN PATENT DOCUMENTS** DOCUMENT SUB-TRANSLATION NO. **CLASS CLASS** YES NO DATE COUNTRY AG AH ΑI **TRANSLATION** OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.) YES NO AJ PATENT ABSTRACTS OF JAPAN of JP 06071706, published March 15, 1994. AK PATENT ABSTRACTS OF JAPAN of JP 07195461, published August 1, 1995. AL PATENT ABSTRACTS OF JAPAN of JP 2001030316, published February 6, 2001. **EXAMINER** DATE CONSIDERED 1-17-66 \*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through

citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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Sheet 1 of 1

PATENT AND TRADEMARK OFFICE

FIRST NAMED INVENTOR

ATTORNEY DOCKET NO.

10/743,072

INFORMATION DISCLOSURE STATEMENT

(Use several sheets if necessary)

Hiroshi WATANABE, et al.

FILING DATE

GROUP ART UNIT

December 23, 2003

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